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## RELIABILITY REPORT

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RELIABILITY DATA LT1022 / OP16					
8/21/2006					
OPERATING LIFE TEST					
PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE HOURS <sup>(1)</sup> AT +125°C	NUMBER OF <sup>(2)</sup> FAILURES
HERMETIC PLASTIC DIP SOIC/SOT/MSOP	80 1,140 50 1,270	9143 9144 9327	9143 9504 9327	82.43 1,174.99 221.76 1,479.18	0 0 0 0
• HIGHLY ACCELERATED STRESS TEST AT +131°C/85%RH					
PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICF HOURS <sup>(4)</sup> AT +85°C	NUMBER OF FAILURES
PLASTIC DIP	202 202	9144	9705	242.40 242.40	0 0
PRESSURE COOKER TEST AT 15 PSIG, +121°C					
PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE HOURS	NUMBER OF FAILURES
PLASTIC DIP SOIC/SOT/MSOP	1,235 100 1,335	9144 9327	9923 9609	50.89 3.60 54.49	0 0 0
• TEMP CYCLE FROM -65°C to +150°C					
PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE CYCLES	NUMBER OF FAILURES
PLASTIC DIP	90 90	9144	9218	9.00 9.00	0 0
• THERMAL SHOCK FROM -65°C to +150°C					
PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE CYCLES	NUMBER OF FAILURES
PLASTIC DIP	138 138	9144	9424	13.80 13.80	0 0
<ul> <li>(1) Assumes Activation Energy = 1.0 Electron Volts</li> <li>(2) Failure Rate Equivalent to +55°C, 60% Confidence Level = 1.24 FITS</li> <li>(3) Mean Time Between Failures in Years = 91,998</li> <li>(4) Assumes 20X Acceleration from 85°C to +131°C</li> <li>Note: 1 FIT = 1 Failure in One Billion Hours.</li> </ul>					
Form: 00-03-6209B_R108					

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